

MOS FIELD EFFECT TRANSISTOR μ PA1818

P-CHANNEL MOS FIELD EFFECT TRANSISTOR FOR SWITCHING

DESCRIPTION

The μ PA1818 is a switching device which can be driven directly by a 2.5 V power source.

This device features a low on-state resistance and excellent switching characteristics, and is suitable for applications such as power management of notebook computers and so on.

FEATURES

- 2.5 V drive available
- · Low on-state resistance

 $R_{DS(on)1} = 15.2 \text{ m}\Omega$ MAX. (Vgs = -4.5 V, ID = -5.0 A)

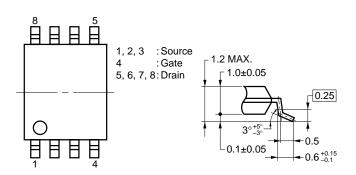
 $R_{DS(on)2} = 16~m\Omega~MAX.~(V_{GS} = -4.0~V,~I_{D} = -5.0~A)$ $R_{DS(on)3} = 25~m\Omega~MAX.~(V_{GS} = -2.5~V,~I_{D} = -5.0~A)$

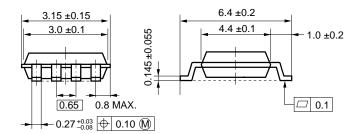
Built-in G-S protection diode against ESD

ORDERING INFORMATION

| PART NUMBER | PACKAGE |
|---------------|--------------|
| μPA1818GR-9JG | Power TSSOP8 |

PACKAGE DRAWING (Unit: mm)

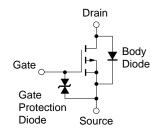




ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

| Drain to Source Voltage (Vgs = 0 V) | VDSS | -20 | V | |
|--|------------------|-------------|----|--|
| Gate to Source Voltage (Vps = 0 V) | Vgss | ∓ 12 | V | |
| Drain Current (DC) (T _A = 25°C) | ID(DC) | ∓ 10 | Α | |
| Drain Current (pulse) Note1 | ID(pulse) | ∓ 40 | Α | |
| Total Power Dissipation Note2 | Рт | 2.0 | W | |
| Channel Temperature | Tch | 150 | °C | |
| Storage Temperature | T _{stg} | -55 to +150 | °C | |

EQUIVALENT CIRCUIT



Notes 1. PW \leq 10 μ s, Duty Cycle \leq 1%

2. Mounted on ceramic substrate of 5000 mm² x 1.1 mm

Remark

The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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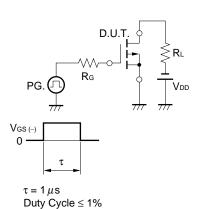
Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.

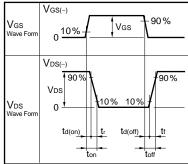


ELECTRICAL CHARACTERISTICS (TA = 25°C)

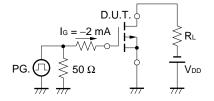
| | | 1 | | | | |
|-------------------------------------|----------------------|---|------|------|------|------|
| CHARACTERISTICS | SYMBOL | TEST CONDITIONS | MIN. | TYP. | MAX. | UNIT |
| Zero Gate Voltage Drain Current | IDSS | V _{DS} = -20 V, V _{GS} = 0 V | | | -1.0 | μΑ |
| Gate Leakage Current | Igss | $V_{GS} = \overline{+} 12 V$, $V_{DS} = 0 V$ | | | ∓ 10 | μΑ |
| Gate Cut-off Voltage | V _{GS(off)} | $V_{DS} = -10 \text{ V}, I_{D} = -1.0 \text{ mA}$ | -0.5 | -1.1 | -1.5 | V |
| Forward Transfer Admittance | y _{fs} | $V_{DS} = -10 \text{ V}, I_{D} = -5.0 \text{ A}$ | 12 | 24 | | S |
| Drain to Source On-state Resistance | RDS(on)1 | $V_{GS} = -4.5 \text{ V}, I_{D} = -5.0 \text{ A}$ | | 12.1 | 15.2 | mΩ |
| | RDS(on)2 | $V_{GS} = -4.0 \text{ V}, I_{D} = -5.0 \text{ A}$ | | 12.7 | 16 | mΩ |
| | RDS(on)3 | $V_{GS} = -2.5 \text{ V}, I_{D} = -5.0 \text{ A}$ | | 18.8 | 25 | mΩ |
| Input Capacitance | Ciss | V _{DS} = −10 V | | 2200 | | pF |
| Output Capacitance | Coss | Vgs = 0 V | | 510 | | pF |
| Reverse Transfer Capacitance | Crss | f = 1.0 MHz | | 310 | | pF |
| Turn-on Delay Time | t _{d(on)} | $V_{DD} = -10 \text{ V}, \text{ ID} = -5.0 \text{ A}$ | | 23 | | ns |
| Rise Time | tr | Vgs = -4.0 V | | 207 | | ns |
| Turn-off Delay Time | t _{d(off)} | $R_G = 10 \Omega$ | | 139 | | ns |
| Fall Time | t f | | | 193 | | ns |
| Total Gate Charge | Q _G | V _{DD} = −16 V | | 20 | | nC |
| Gate to Source Charge | Qgs | Vgs = -4.0 V | | 5.0 | | nC |
| Gate to Drain Charge | Q _{GD} | I _D = −10 A | | 6.0 | | nC |
| Body Diode Forward Voltage | V _{F(S-D)} | IF = 10 A, VGS = 0 V | | 0.82 | | V |
| Reverse Recovery Time | trr | IF = 10 A, VGS = 0 V | | 44 | | ns |
| Reverse Recovery Charge | Qrr | di/dt = 100 A / μ s | | 28 | | nC |

TEST CIRCUIT 1 SWITCHING TIME

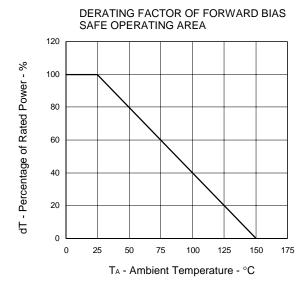




TEST CIRCUIT 2 GATE CHARGE



TYPICAL CHARACTERISTICS (TA = 25°C)



AMBIENT TEMPERATURE 2.5 2 Mounted on ceramic substrate of 5000 mm² x 1.1 mm 1.5

100

TA - Ambient Temperature - °C

125

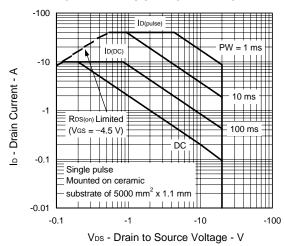
150

175

Mounted on FR-4 board of 2500 mm² x 1.6 mm

TOTAL POWER DISSIPATION vs.

FORWARD BIAS SAFE OPERATING AREA



TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

P_T - Total Power Dissipation - W

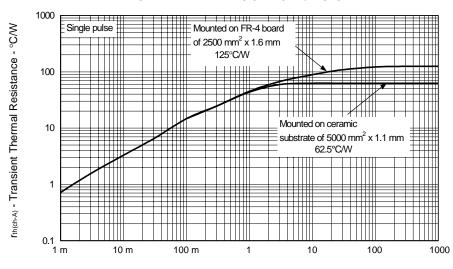
1

0.5

0

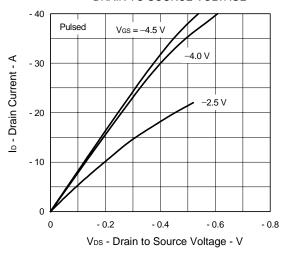
0

25

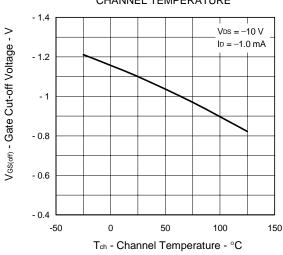


PW - Pulse Width - s

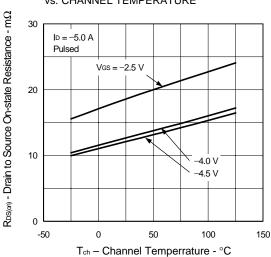
DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



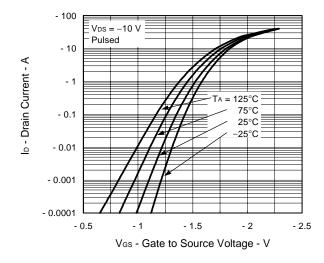
GATE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE



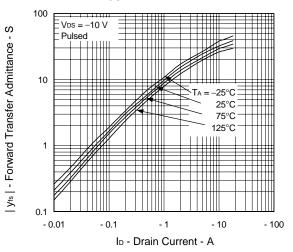
DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE



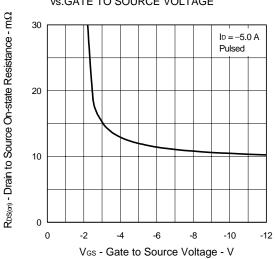
FORWARD TRANSFER CHARACTERISTICS



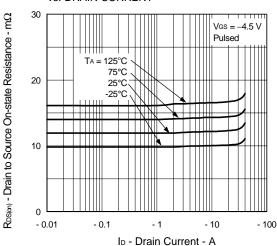
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



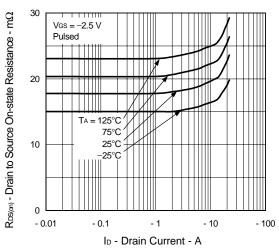
DRAIN TO SOURCE ON-STATE RESISTANCE vs.GATE TO SOURCE VOLTAGE



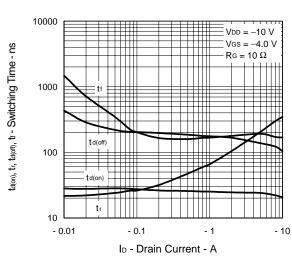
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



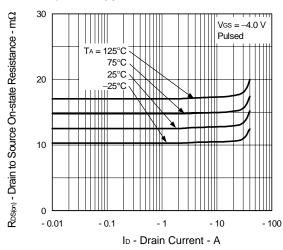
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



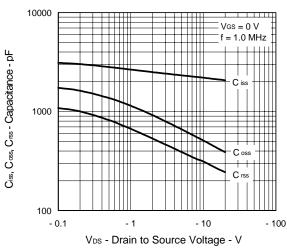
SWITCHING CHARACTERISTICS



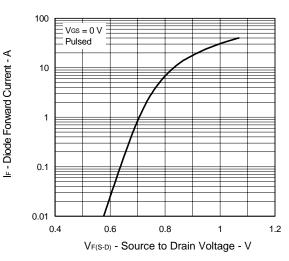
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



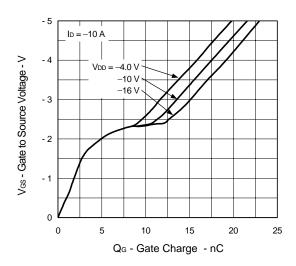
CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



SOURCE TO DRAIN DIODE FORWARD VOLTAGE



DYNAMIC INPUT/OUTPUT CHARACTERISTICS



NEC μ PA1818

[MEMO]

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